

Search Notes

Application/Control No.

10/638,218

Examiner

Nam V. Nguyen

Applicant(s)/Patent under
Reexamination

SINGH, ABHISHEK

Art Unit

2635

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 340 | 5.2 | 11/1/2005 | NN |
| 340 | 5.28 | 11/1/2005 | NN |
| 340 | 5.3+ | 11/1/2005 | NN |
| 340 | 5.7+ | 11/1/2005 | NN |
| 340 | 5.8+ | 11/1/2005 | NN |
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| 382 | 115 | 11/1/2005 | NN |
| 382 | 116 | 11/1/2005 | NN |
| 382 | 187 | 11/1/2005 | NN |
| 382 | 124 | 11/1/2005 | NN |
| | | | |
| 235 | 380 | 11/1/2005 | NN |
| 235 | 384 | 11/1/2005 | NN |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| East Search: USPAT; US-PUB; EPO; JPO and Derwent. (UPDATED SEARCH). | 11/1/2005 | NN |
| Consult with Benjamin Lee | 6/23/2005 | NN |
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